

<b>Notice of References Cited</b>	Application/Control No. 10/714,404	Applicant(s)/Patent Under Reexamination AHN ET AL.	
	Examiner Ryan Gleitz	Art Unit 2852	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,218,132	08-1980	Iwai et al.	399/358
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 57172366 A	10-1982	Japan	OKADA et al.	G03G 15/08
	O	JP 03080284 A	04-1991	Japan	ISHII, MASAHIRO	G03G 21/00
	P	JP 2001312190 A	11-2001	Japan	HIRAMATSU et al.	G03G 21/10
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.